## Notice of References Cited

Application/Control No. 10/000,210 Applicant(s)/Patent Under Reexam Heil et al.

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Vanaman

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## U.S. PATENT DOCUMENTS

Document Number Date Country Code-Number-Kind Code MM-YYYY		. Date MM-YYYY¹	Name	Clas	Classification 2	
A	5,022,679	6/1991	Pazik	280	164.1	
В	6,412,799 B1	7/2002	Schrempf (filed 6/2000)	280	163	
С	6,513,821 B1	2/2003	Heil (filed 8/2000)	280	163	
D	2003/0006576 A1	1/2003	- Lanoue et al. (filed 6/2002)	280	163	
E						
F						
G						
н						
1						
J						
K						
L						
м				_		

## FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY¹	Country	Name	Class	Classification <sup>2</sup>	
N	59-32535	2/1984	JP	Kobayashi et al.	280	166	
0	2-92786	4/1990	JP	Yamana	280	163	
Р	5-85267	4/1993	JP	Nakao et al.	280	169	
a							
R							
s							
т							

## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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w	
x	

<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>&</sup>lt;sup>2</sup> Classifications may be U.S. or foreign.